

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination AHN ET AL.	
		Examiner KEATH T. CHEN	Art Unit 1792	Page 1 of 1

U.S. PATENT DOCUMENTS

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A US-6,439,943	08-2002	Aoki et al.	445/24
*	B US-2003/0180458	09-2003	Sneh, Ofer	427/248.1
C	US-			
D	US-			
E	US-			
F	US-			
G	US-			
H	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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